

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	10/022732	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 08:22
L2	29	(inspection adj pad) and (bonding adj pad)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:20
L3	614	((inspection or test) adj pad) and (bonding adj pad)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:07
L4	394	((inspection or test) adj pad) and (bonding adj pad) and wire	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:07
L5	114	"324"/\$.ccls. and 4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:16
L6	18	"29"/\$.ccls. and 4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:17
L7	23	"361"/\$.ccls. and 4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:17
L8	93	("4467400").URPN.	USPAT	OR	ON	2006/12/19 09:20
L9	0	((semiconductor adj integrated adj device) and (inspection adj pad) and (bonding adj pad)).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:21
L10	1	((semiconductor adj integrated adj device) and (inspection adj pad) and (bonding adj pad)).clm"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2006/12/19 09:23

EAST Search History

L11	7	(("6640198") or ("6317853") or ("7036060")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	OFF	2006/12/19 09:25
L12	2	("5059899").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	OFF	2006/12/19 09:25
L13	121	("5059899").URPN.	USPAT	OR	ON	2006/12/19 09:25